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3D X-DRAM™

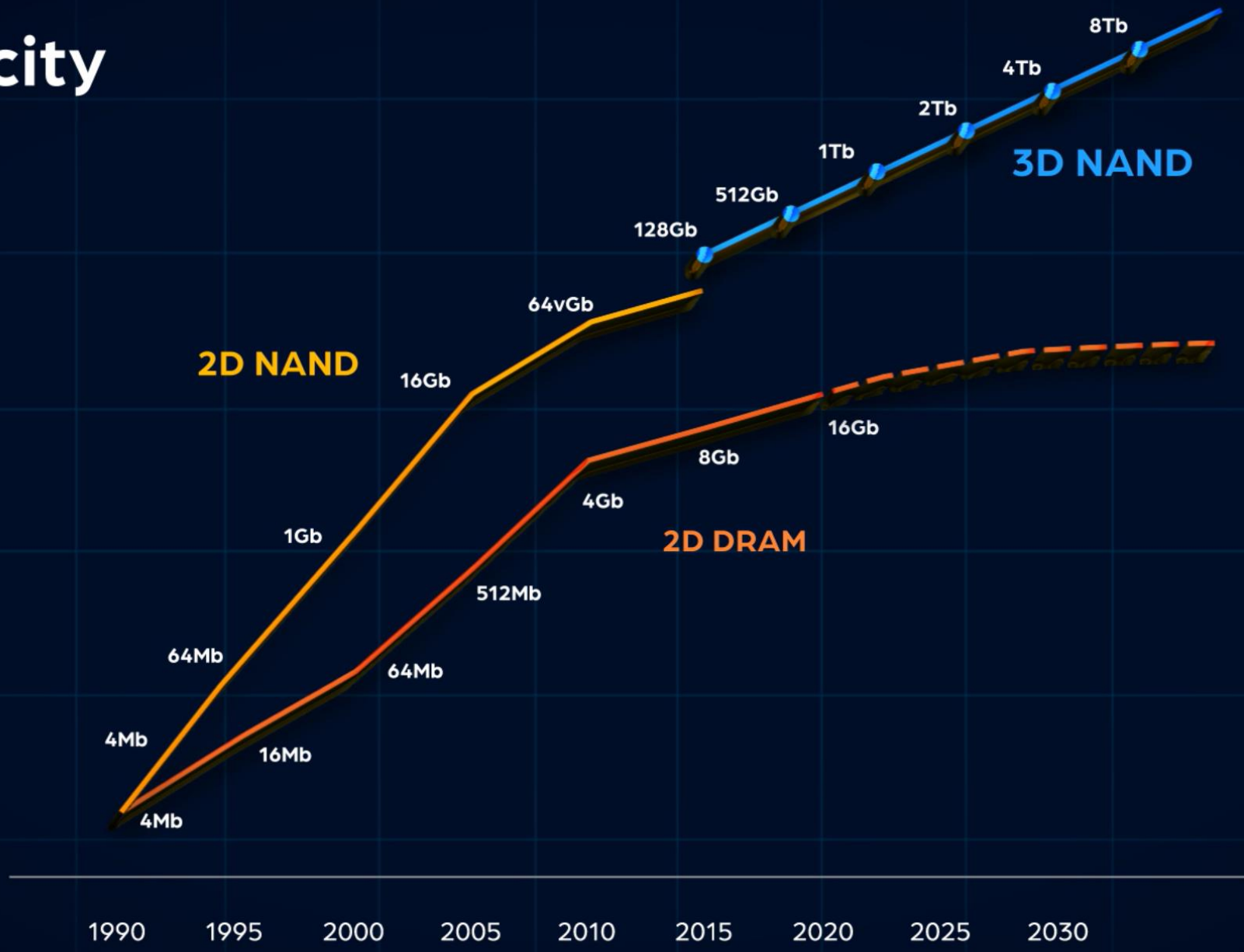
World's First 3D NAND-like DRAM

August 2023

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Presentation | 3D X-DRAM™ Technology

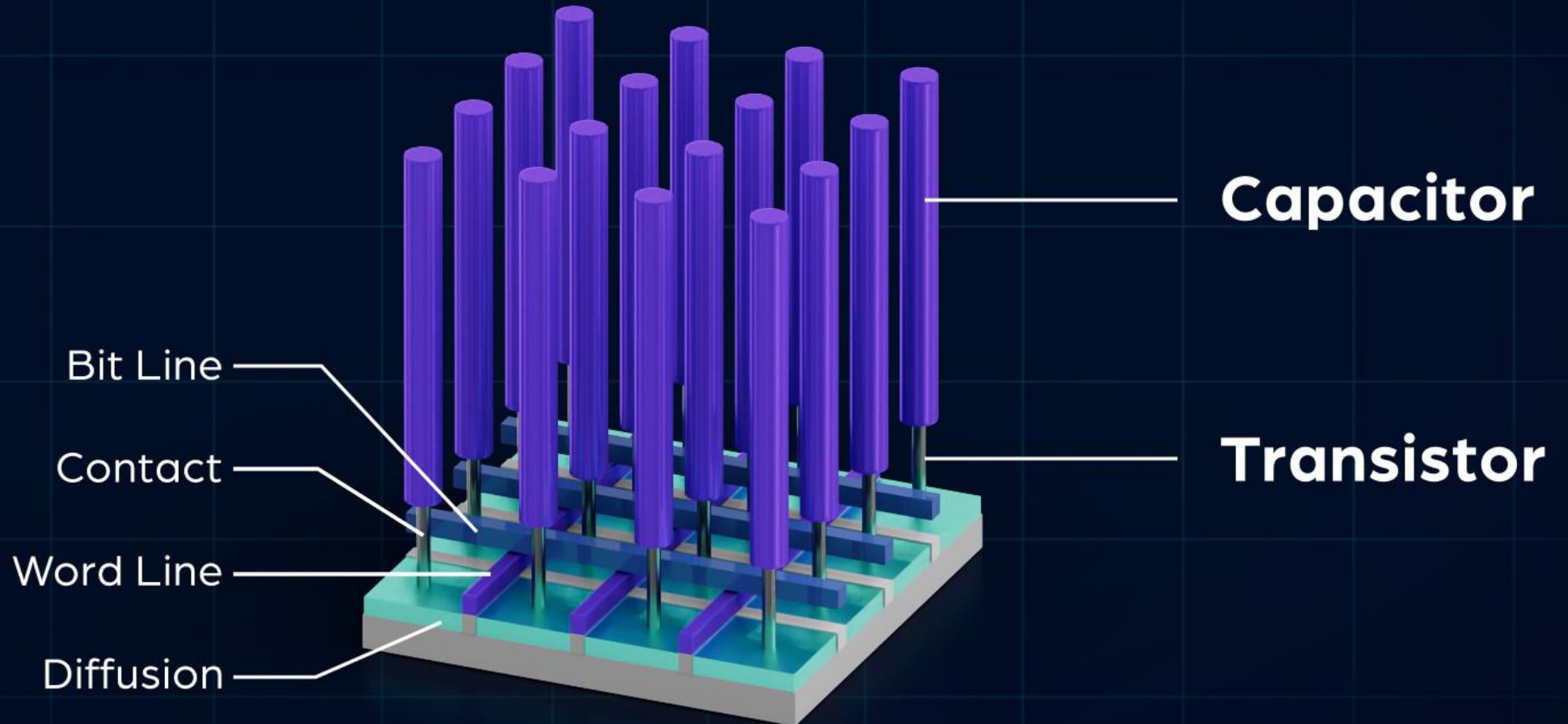
Capacity

2D DRAM

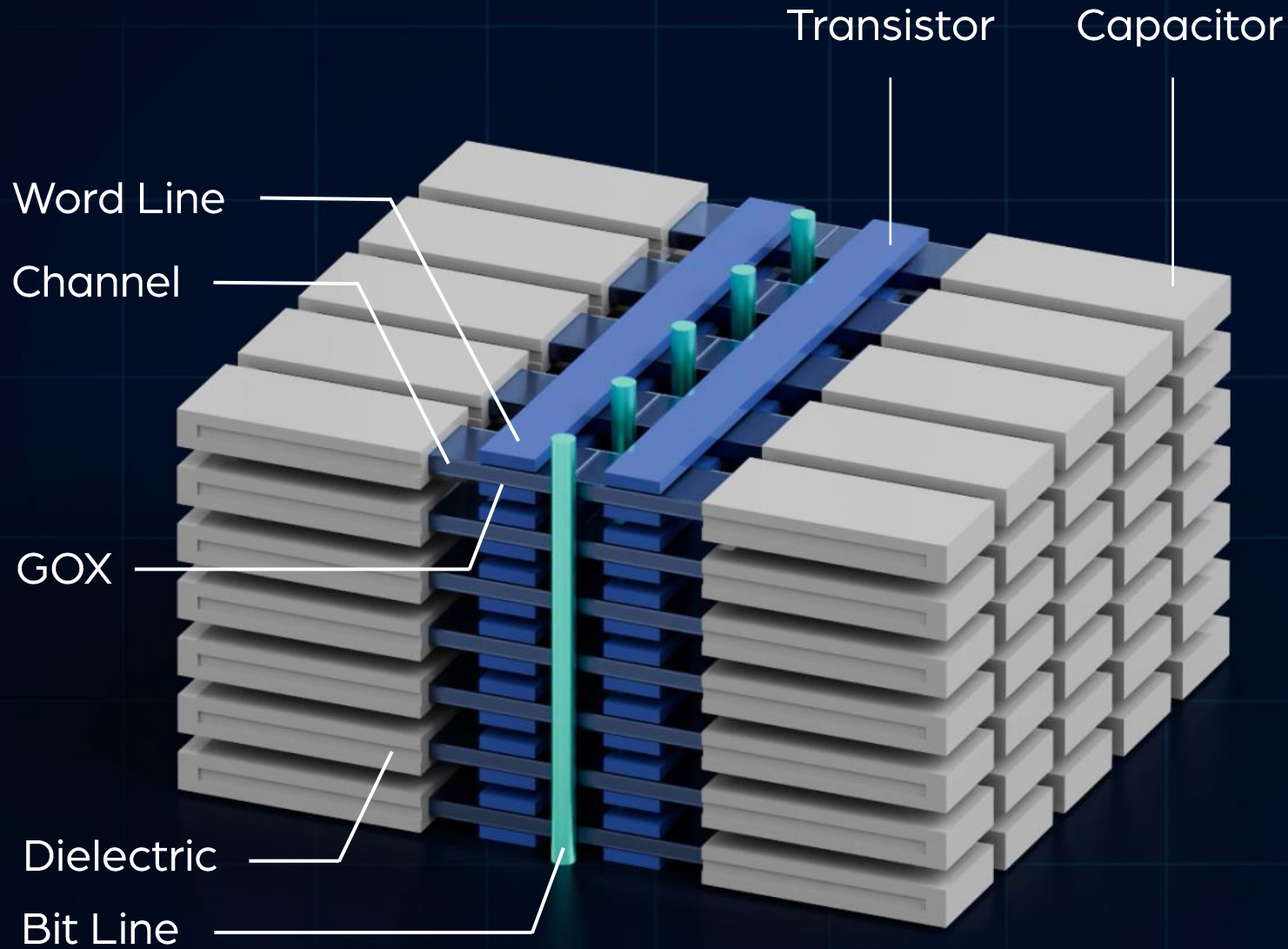


2D DRAM

Not Scalable
beyond **10 nm**



3D DRAM



Complicated

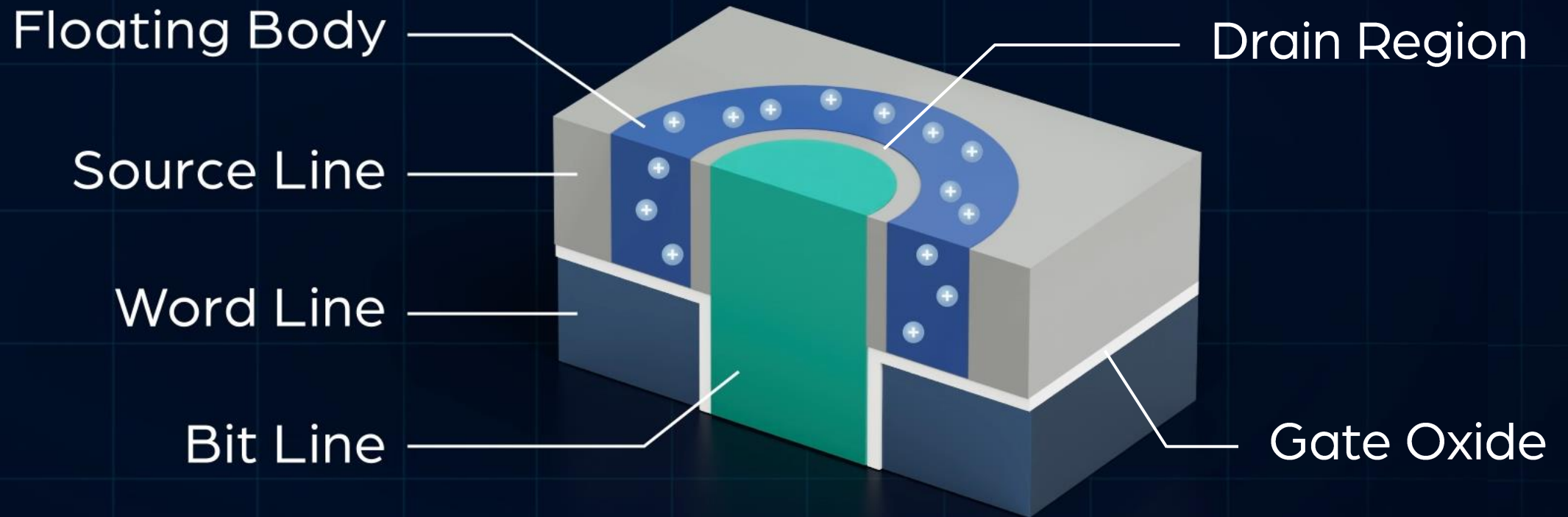
Large Cell Size

Process Challenge

Low Yield

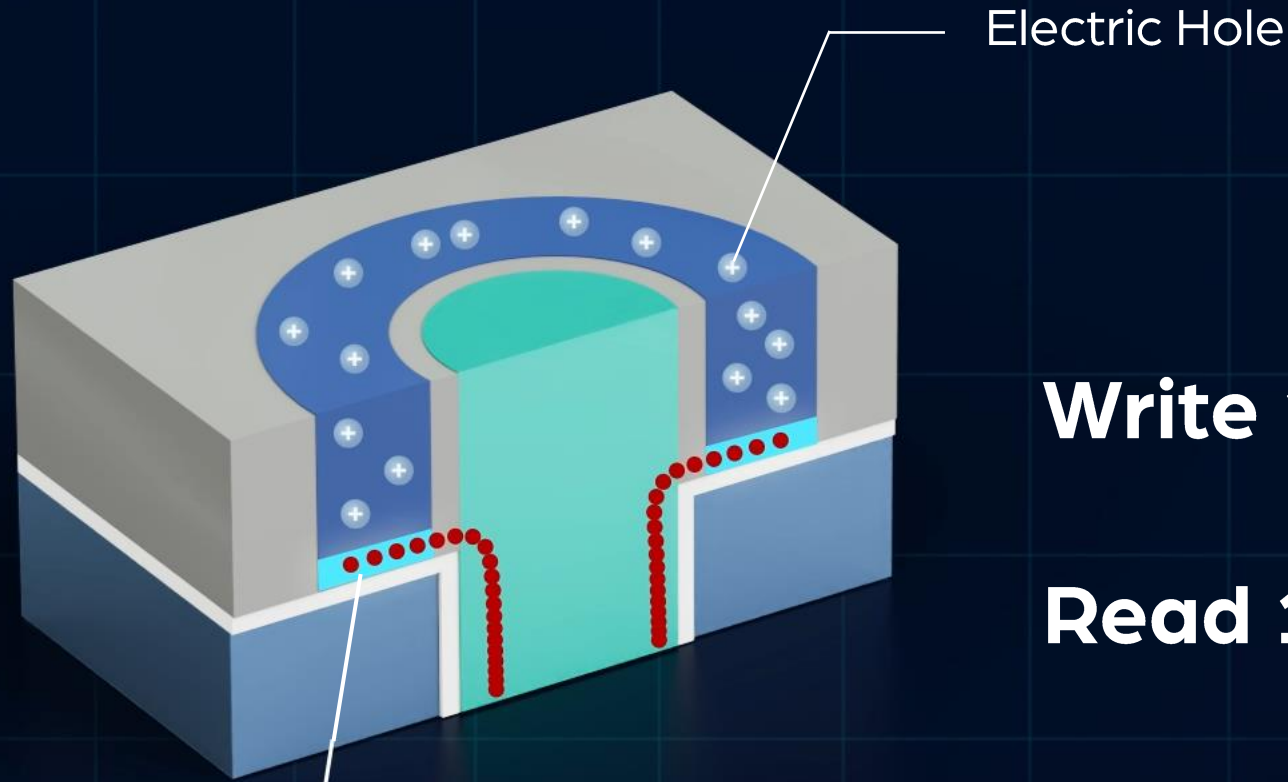
3D X-DRAM™ Cell Structure

Based on Capacitor-less
Floating Body Cell Technology



3D X-DRAM

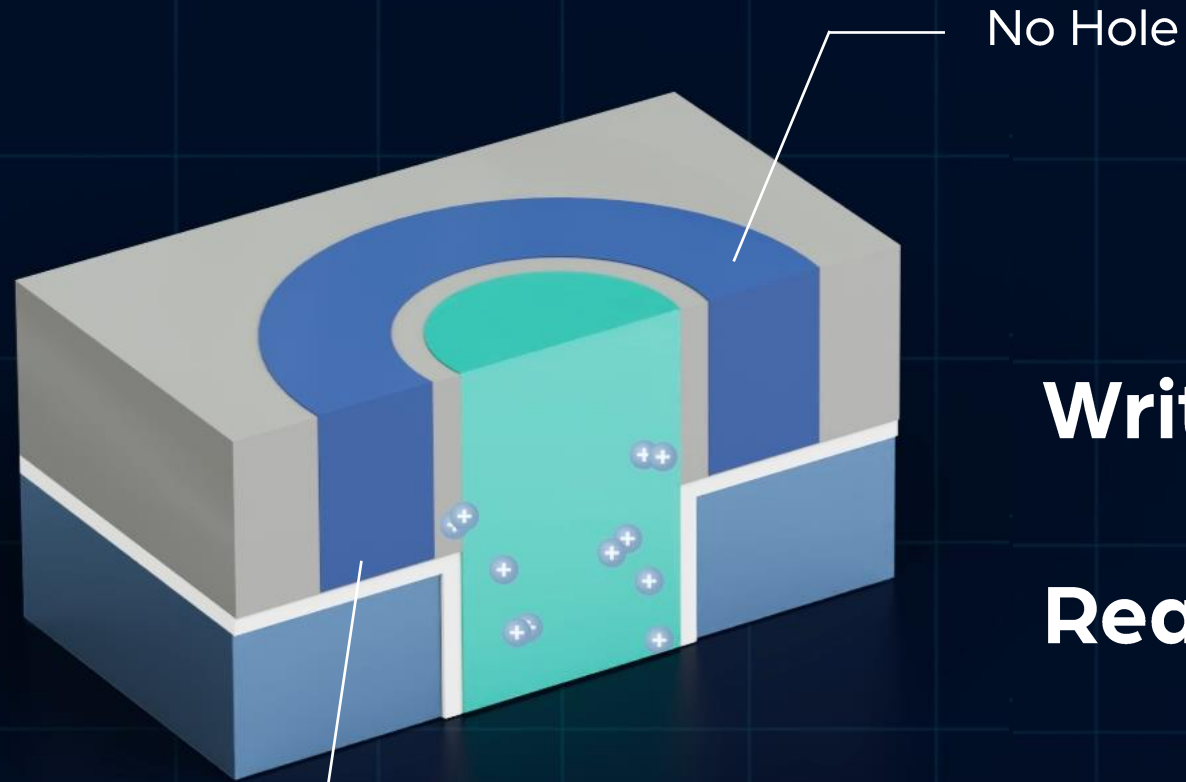
3D X-DRAM™ Operations



Write 1 > Impact Ionization

Read 1 > On cell

3D X-DRAM™ Operations



Write 0 > Forward Bias

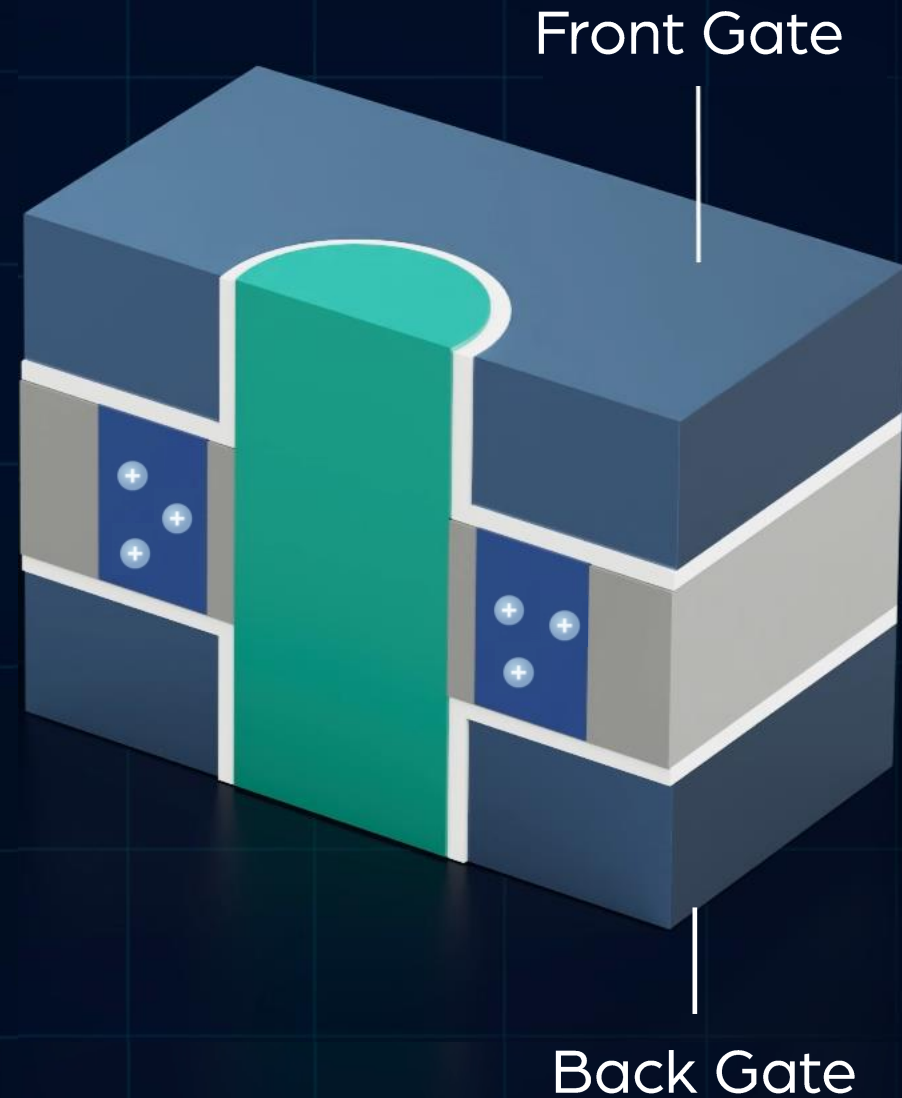
Read 0 > Off cell

3D X-DRAM™ Performance

Non-destructive
Read

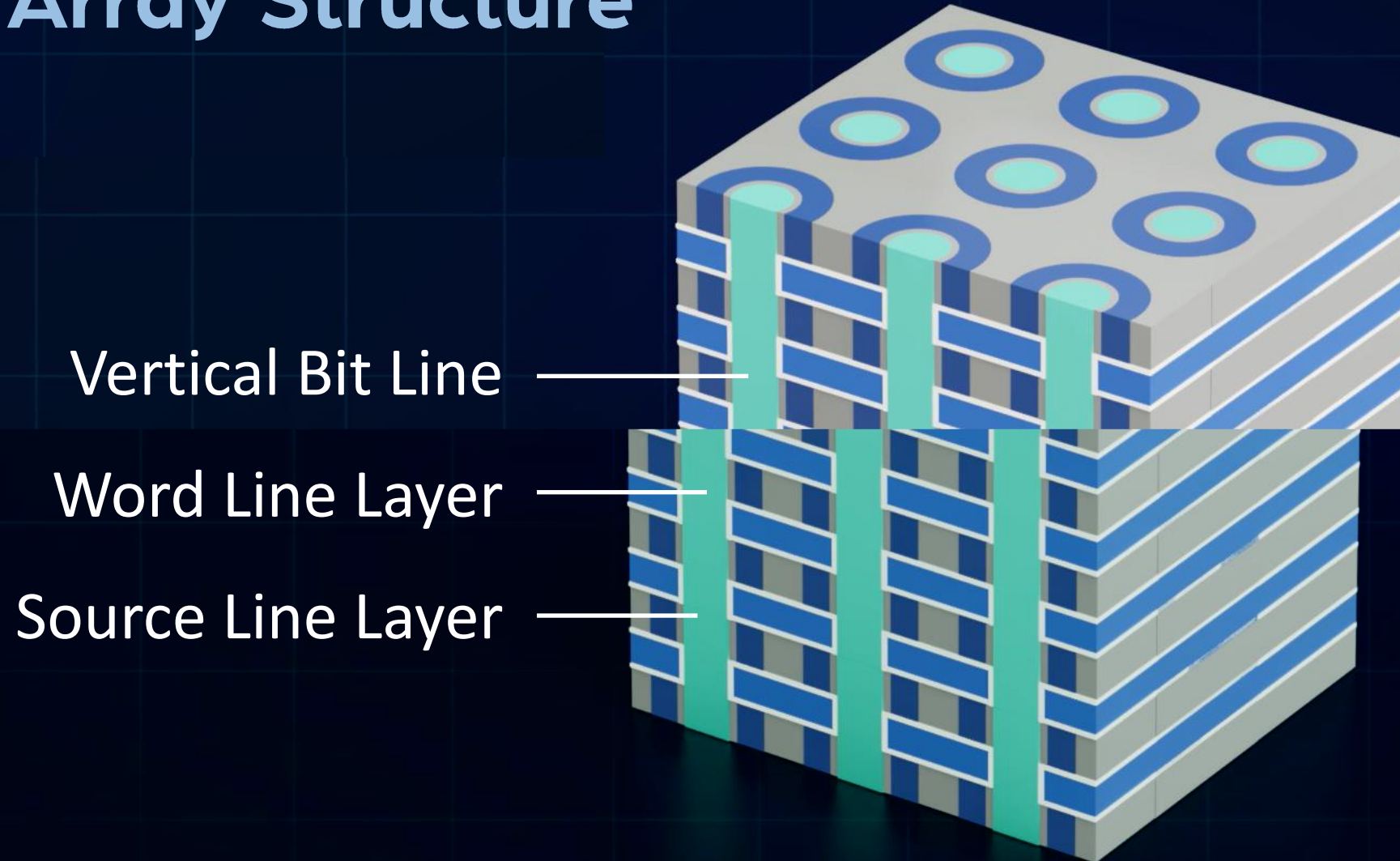
Dual-Gate
Structure

Increase
Data Retention Time



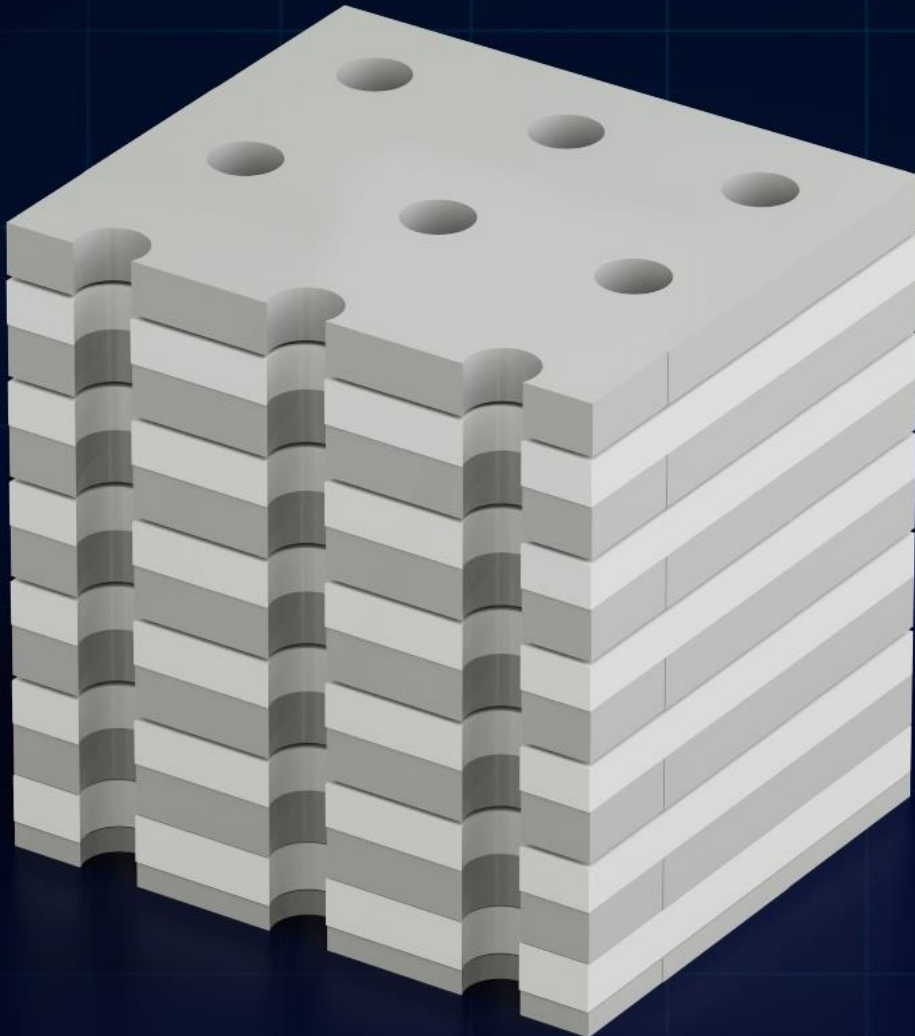
3D X-DRAM™ Array Structure

3D NAND-like Array



3D X-DRAM

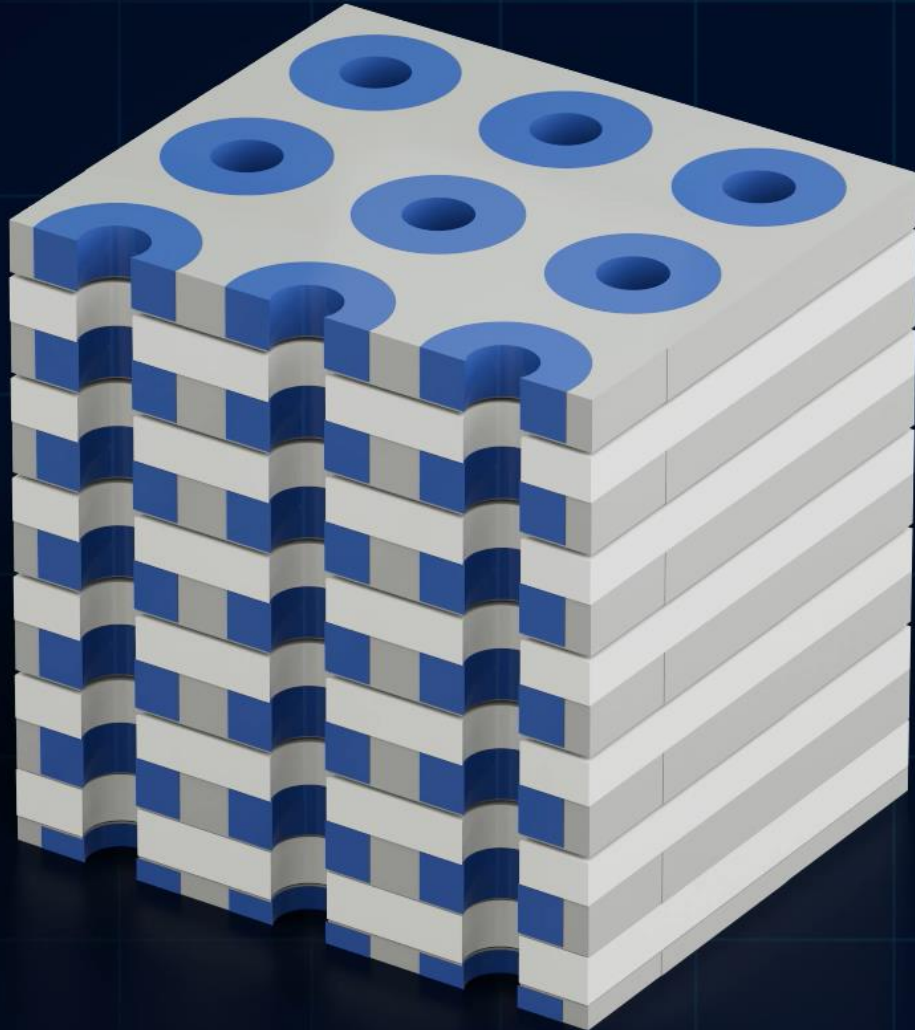
3D X-DRAM™ Process Steps



3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes

3D X-DRAM™ Process Steps



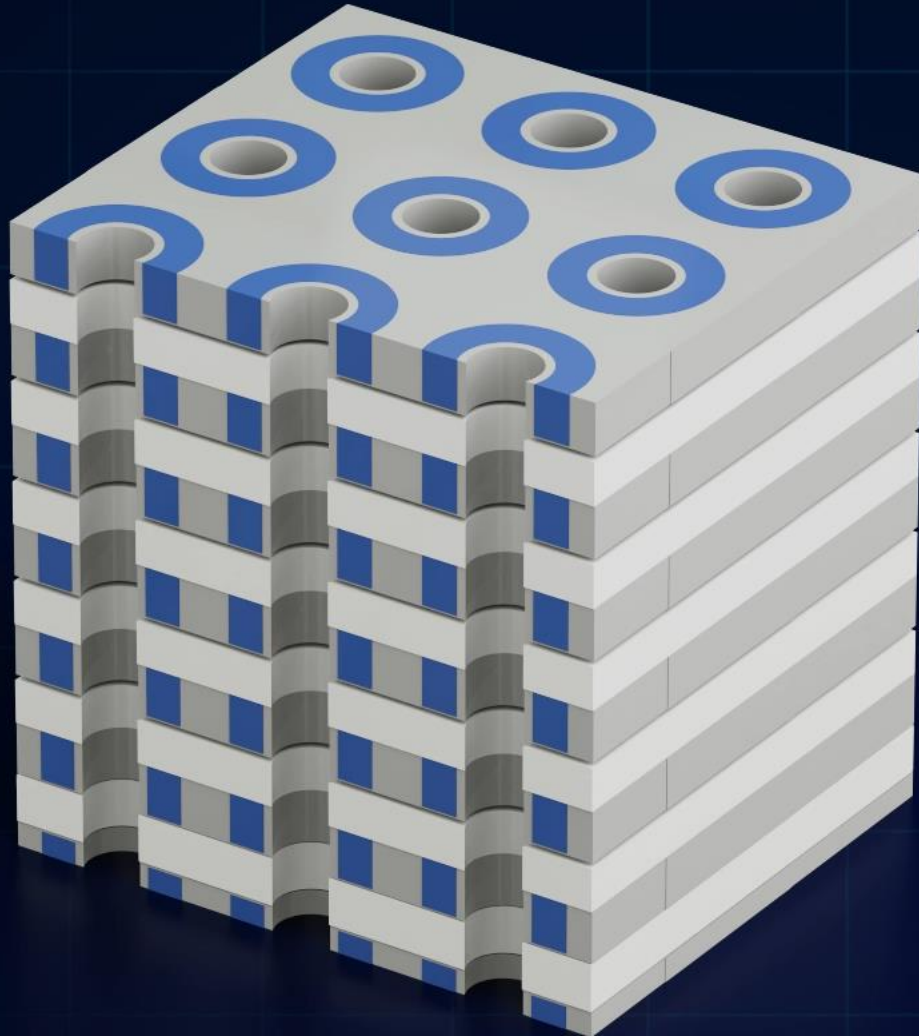
3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body

3D X-DRAM™

Process Steps

3D X-DRAM

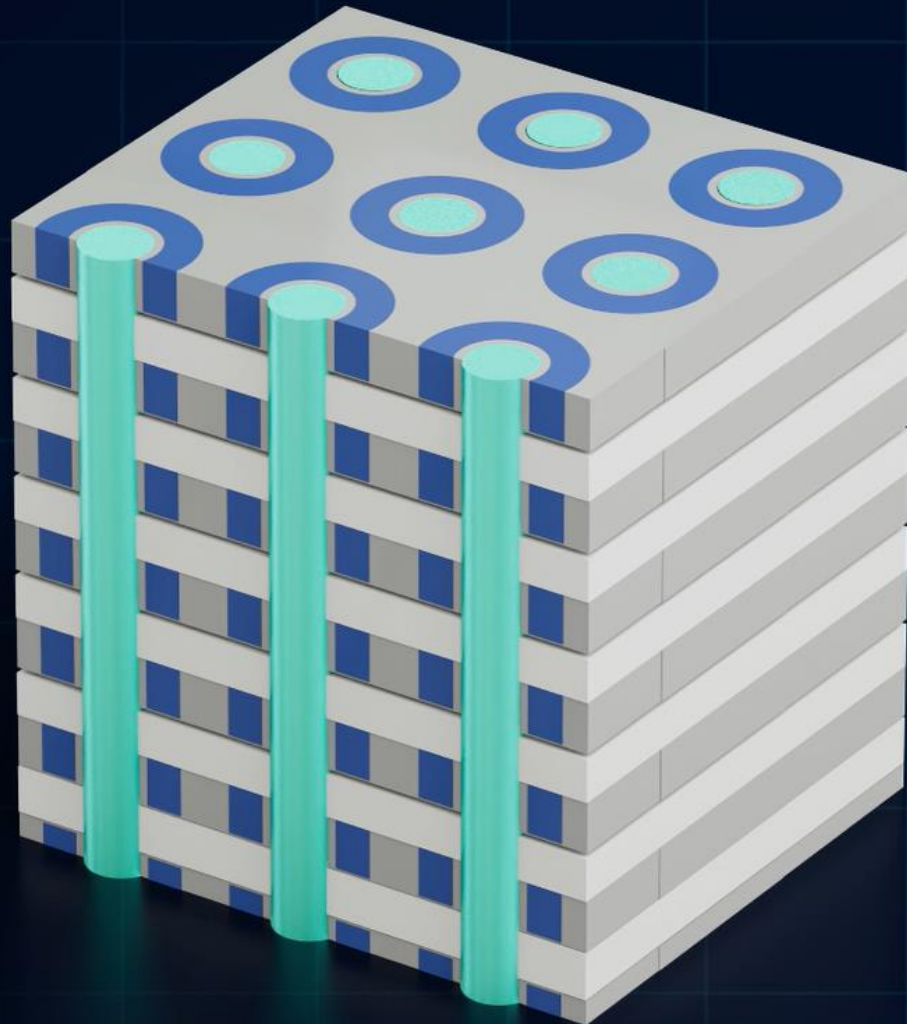


3D

NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body
- 4 Deposit Polysilicon Layer

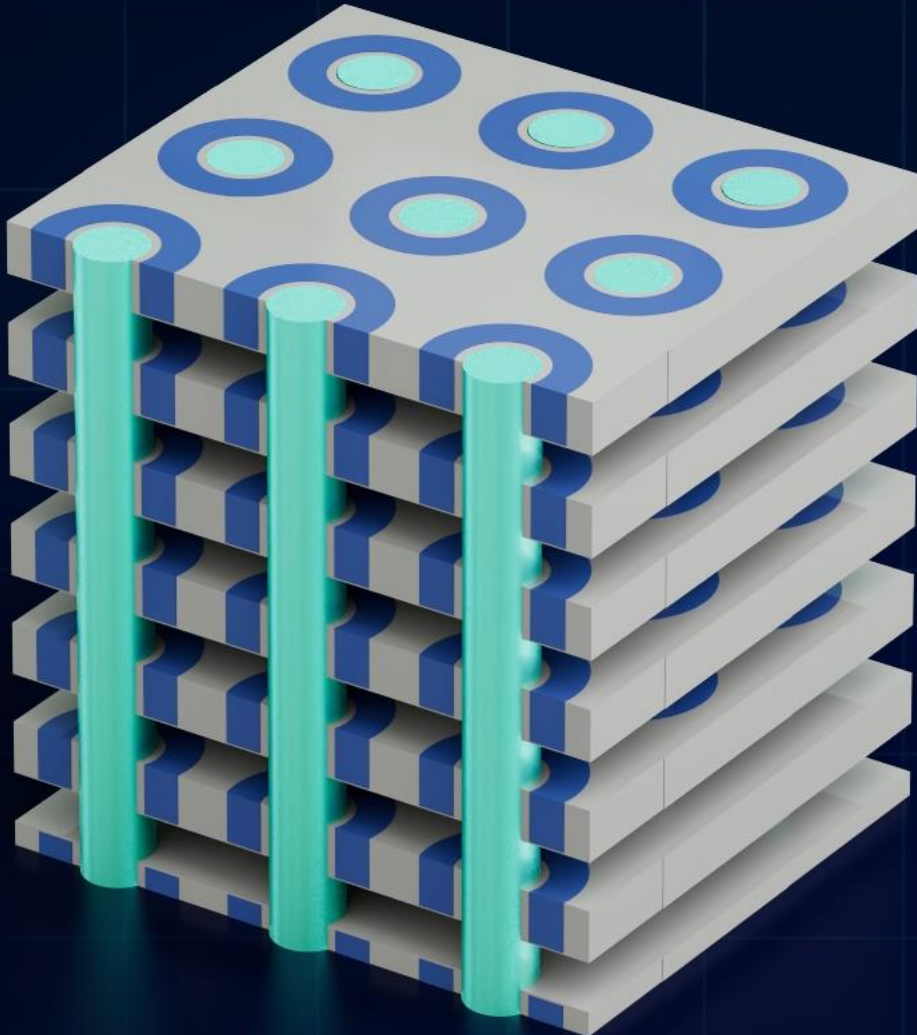
3D X-DRAM™ Process Steps



3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body
- 4 Deposit Polysilicon Layer
- 5 Metal Fill Bit Line Hole

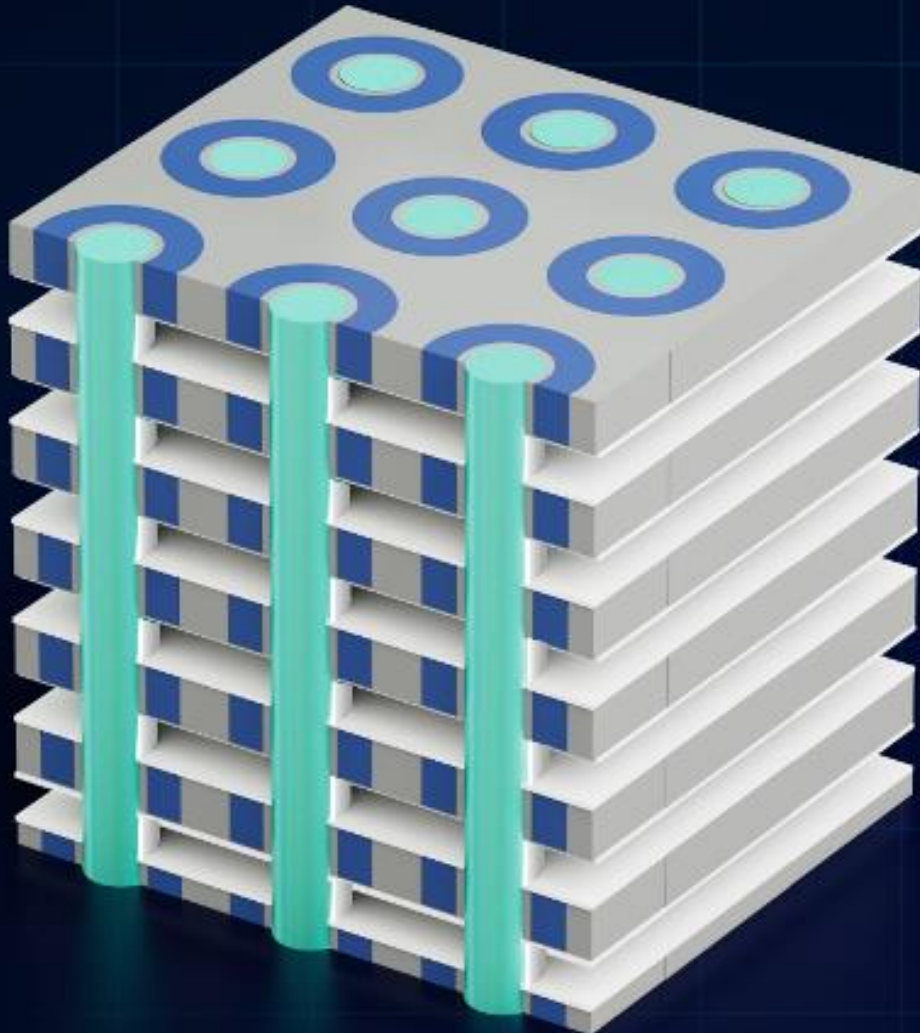
3D X-DRAM™ Process Steps



3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body
- 4 Deposit Polysilicon Layer
- 5 Metal Fill Bit Line Hole
- 6 Wet Etch Nitride Layers

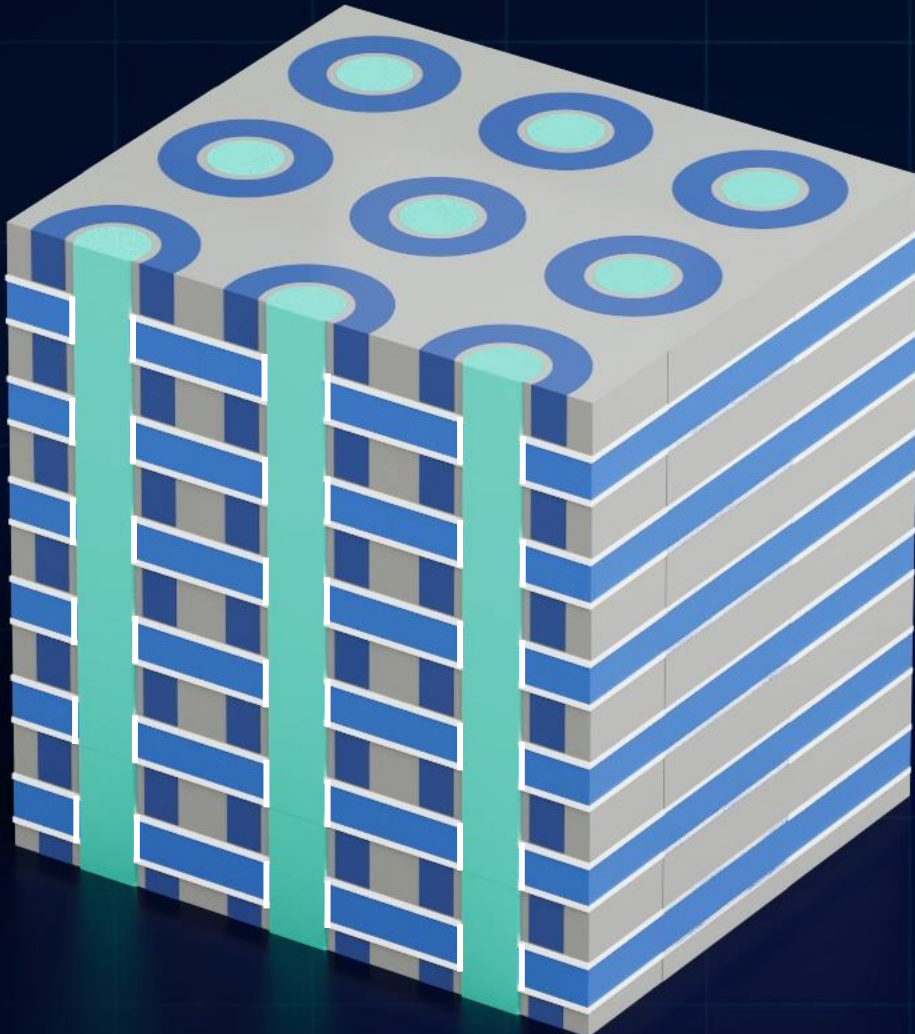
3D X-DRAM™ Process Steps



3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body
- 4 Deposit Polysilicon Layer
- 5 Metal Fill Bit Line Hole
- 6 Wet Etch Nitride Layers
- 7 Deposit Gate Oxide Layer

3D X-DRAM™ Process Steps



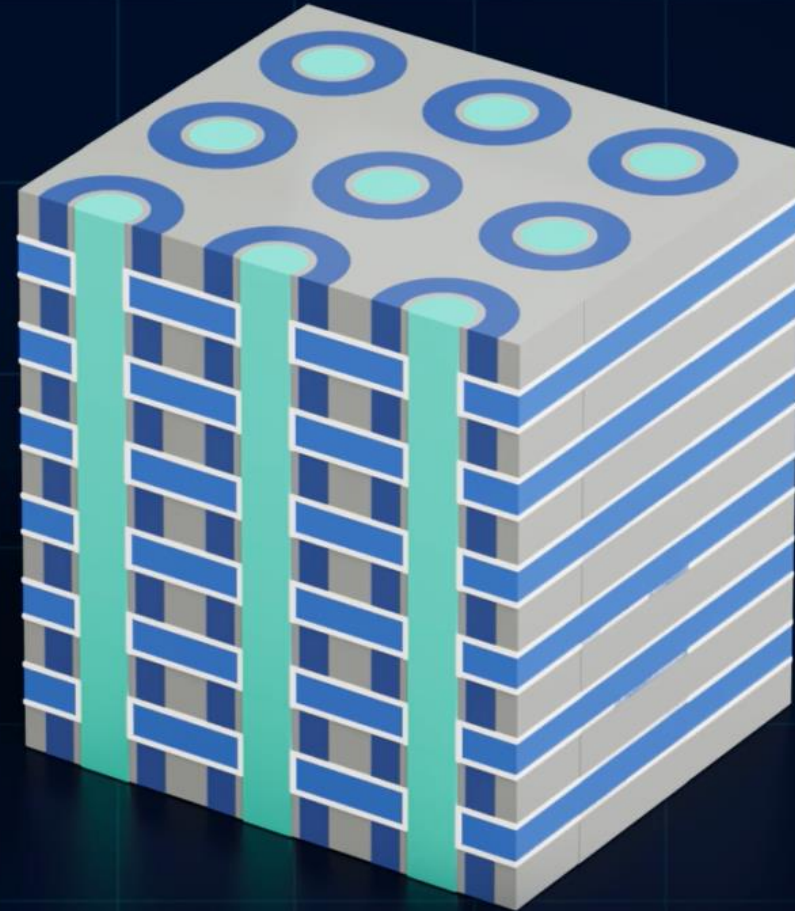
3D NAND-like Process

- 1 Deposit Multiple Layers
- 2 Deep Trench Bit Line Holes
- 3 Plasma Doping for Floating Body
- 4 Deposit Polysilicon Layer
- 5 Metal Fill Bit Line Hole
- 6 Wet Etch Nitride Layers
- 7 Deposit Gate Oxide Layer
- 8 Deposit Metal Word Lines

3D X-DRAM™

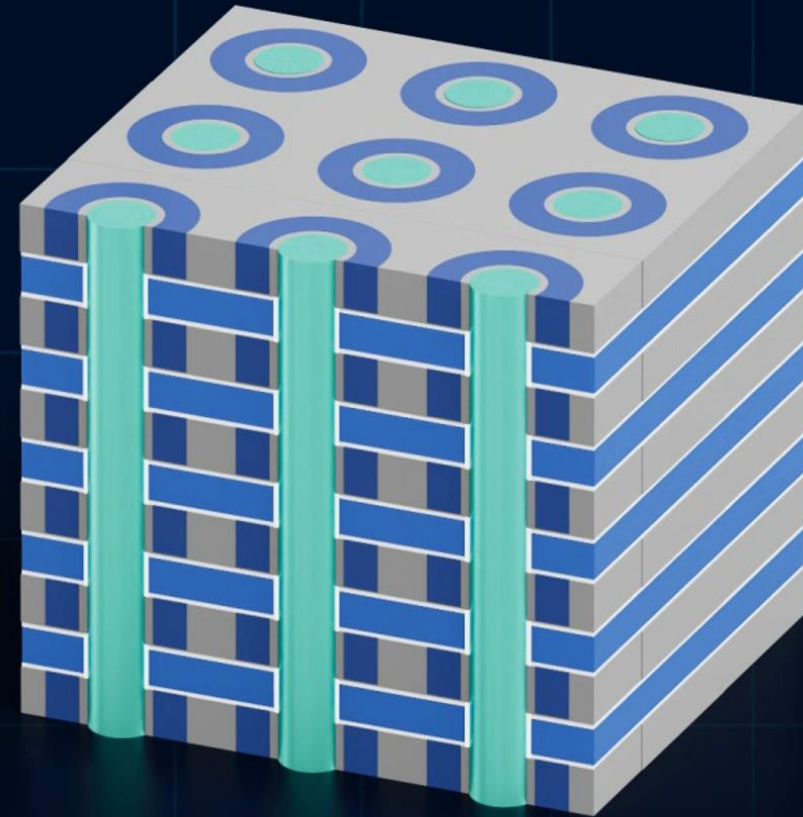
Process Advantages

- 1 Bit Line Mask
- 8 Key Steps
 - Self-Aligned



3D NAND

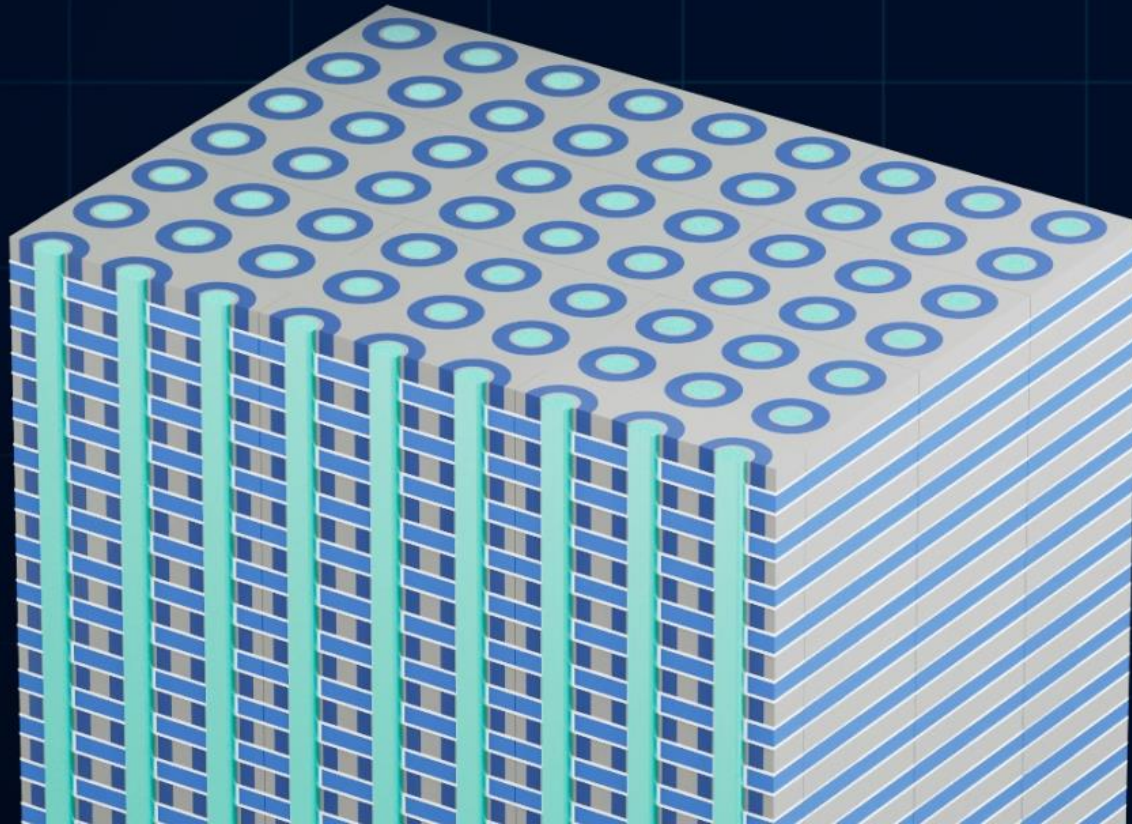
3D X-DRAM



Similar Processes

3D X-DRAM™ Memory Density

3D X-DRAM



230 Layers

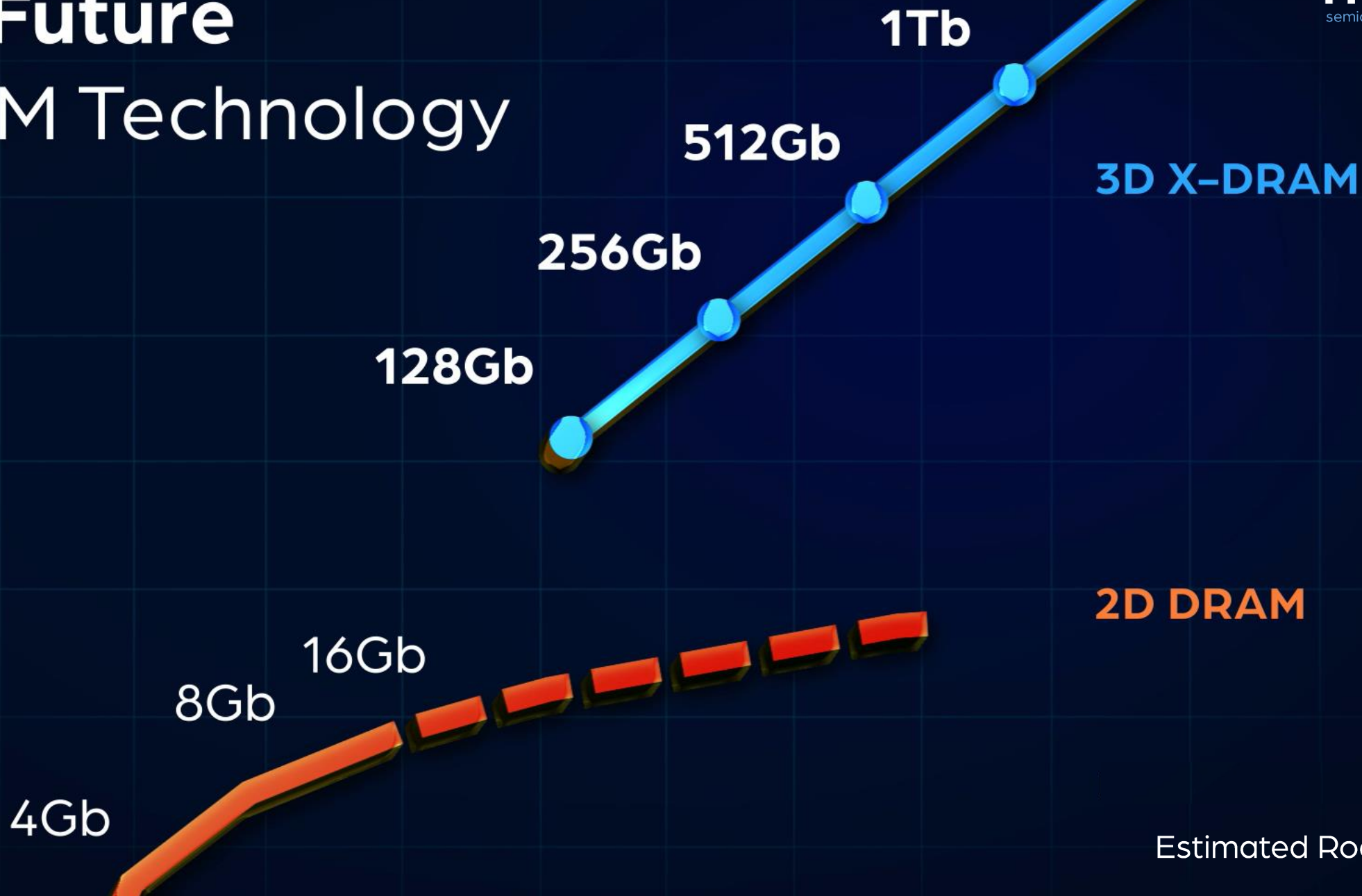
128 Gb

8X Density

Estimated Density

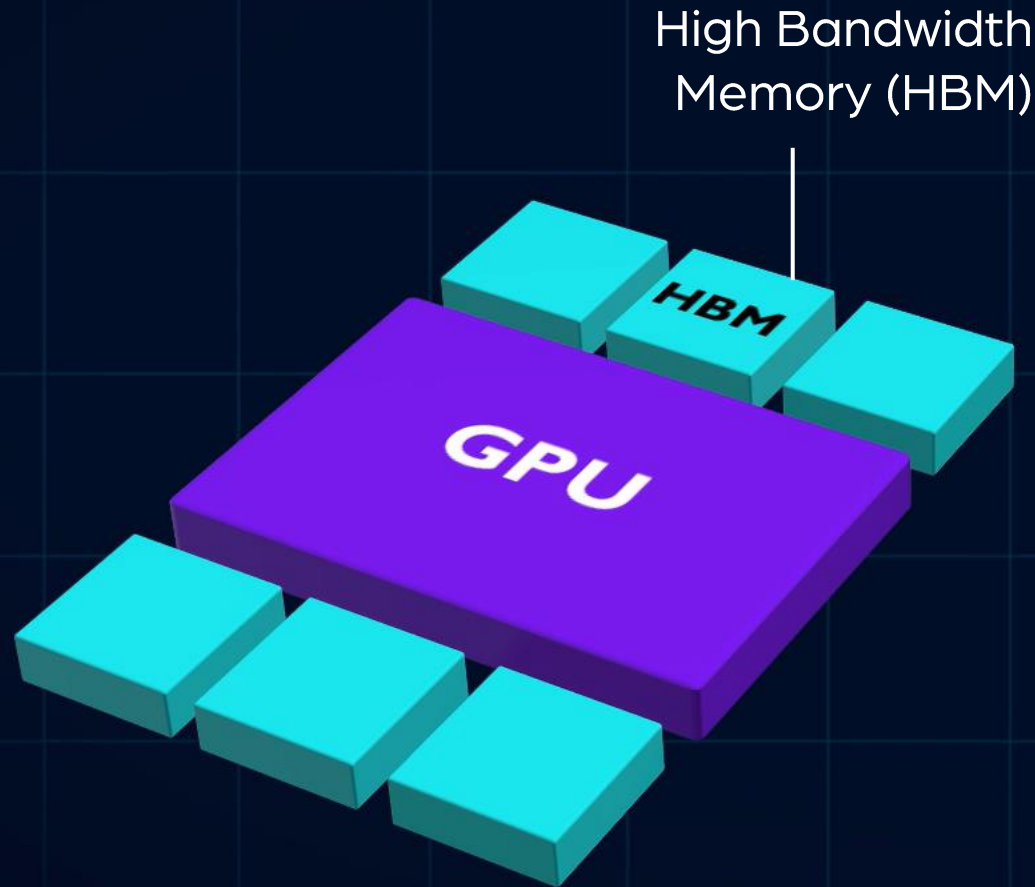
The Future DRAM Technology

3D X-DRAM



More Memory for AI Chip

AI Application



3D X-DRAM

1.5 TB

2D DRAM

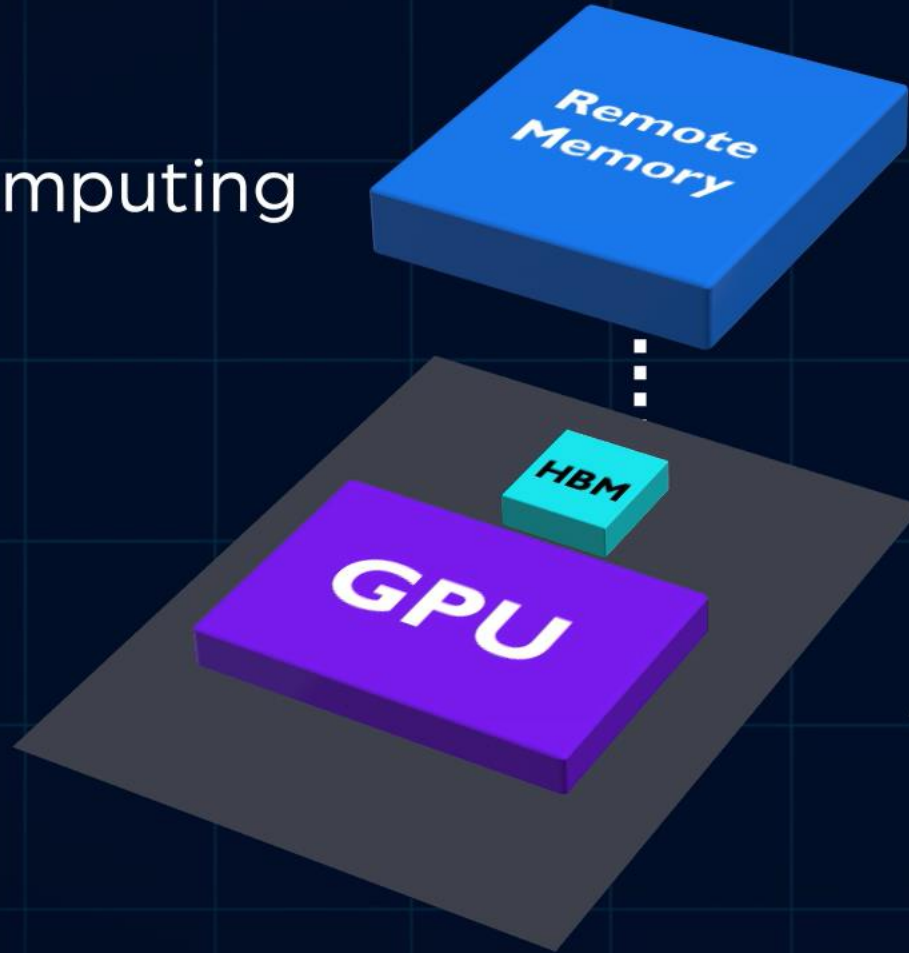
192 GB



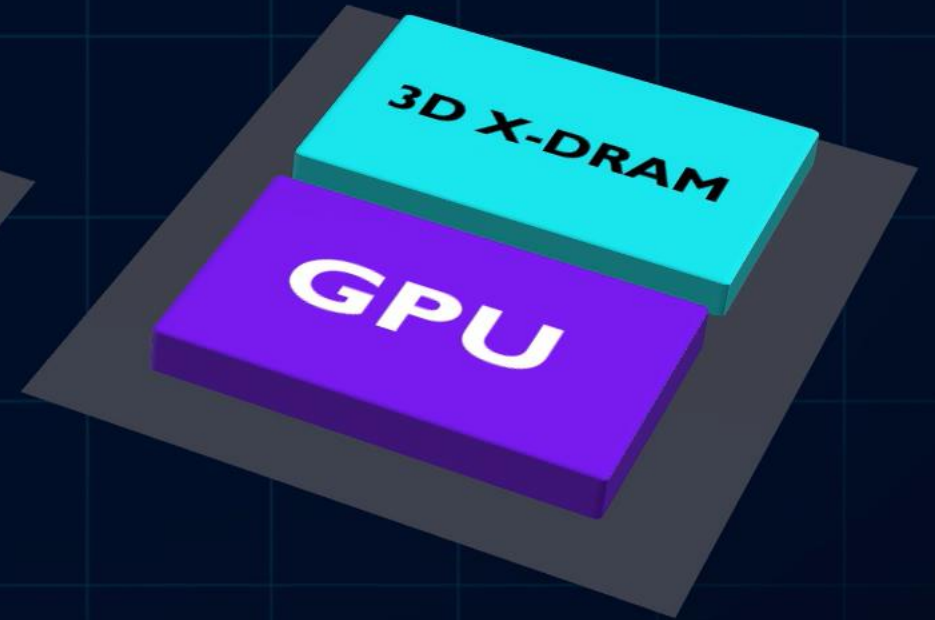
Estimated Capacity

AI Revolution

Remote
Memory Computing



Local
Memory Computing





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Thank You

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3D X-DRAM Tech 5G